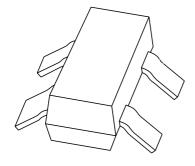
DISCRETE SEMICONDUCTORS

DATA SHEET



BAS28High-speed double diode

Product data sheet Supersedes data of April 1996



High-speed double diode

BAS28

FEATURES

- Small plastic SMD package
- High switching speed: max. 4 ns
- Continuous reverse voltage: max. 75 V
- Repetitive peak reverse voltage: max. 85 V
- Repetitive peak forward current: max. 500 mA.

APPLICATIONS

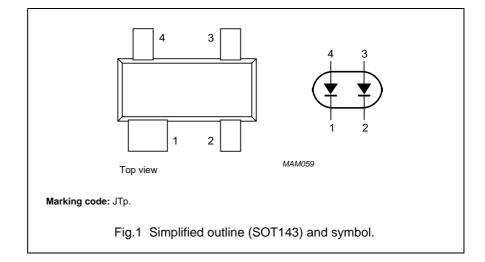
 High-speed switching in e.g. surface mounted circuits.

DESCRIPTION

The BAS28 consists of two high-speed switching diodes, fabricated in planar technology, and encapsulated in the small plastic SMD SOT143 package. The diodes are not connected.

PINNING

PIN	DESCRIPTION
1	cathode (k1)
2	cathode (k2)
3	anode (a2)
4	anode (a1)



LIMITING VALUES

In accordance with the Absolute Maximum Rating System (IEC 134).

SYMBOL	PARAMETER	CONDITIONS	MIN.	MAX.	UNIT
V_{RRM}	repetitive peak reverse voltage		_	85	V
V_R	continuous reverse voltage		-	75	V
I _F	continuous forward current	see Fig.2; note 1	_	215	mA
I _{FRM}	repetitive peak forward current		-	500	mA
I _{FSM}	non-repetitive peak forward current	square wave; $T_j = 25$ °C prior to surge; see Fig.4			
		t = 1 μs	-	4	Α
		t = 1 ms	_	1	Α
		t = 1 s	_	0.5	Α
P _{tot}	total power dissipation	T _{amb} = 25 °C; note 1	_	250	mW
T _{stg}	storage temperature		-65	+150	°C
Tj	junction temperature		_	150	°C

Note

1. Device mounted on an FR4 printed-circuit board.

High-speed double diode

BAS28

ELECTRICAL CHARACTERISTICS

 $T_j = 25$ °C; unless otherwise specified.

SYMBOL	PARAMETER	CONDITIONS	MIN.	MAX.	UNIT
V _F	forward voltage	see Fig.3			
		I _F = 1 mA	_	715	mV
		I _F = 10 mA	_	855	mV
		I _F = 50 mA	_	1	V
		I _F = 150 mA	_	1.25	V
I _R	reverse current	see Fig.5			
		V _R = 25 V	_	30	nA
		V _R = 75 V	_	1	μΑ
		V _R = 25 V; T _j = 150 °C	_	30	μΑ
		V _R = 75 V; T _j = 150 °C	_	50	μΑ
C _d	diode capacitance	f = 1 MHz; V _R = 0; see Fig.6	_	1.5	pF
t _{rr}	reverse recovery time	when switched from I _F = 10 mA to	_	4	ns
		$I_R = 10 \text{ mA}$; $R_L = 100 \Omega$; measured			
		at I _R = 1 mA; see Fig.7			
V_{fr}	forward recovery voltage	when switched from $I_F = 10 \text{ mA}$;	_	1.75	V
		$t_r = 20 \text{ ns}$; see Fig.8			

THERMAL CHARACTERISTICS

SYMBOL	PARAMETER	CONDITIONS	VALUE	UNIT
R _{th j-tp}	thermal resistance from junction to tie-point		360	K/W
R _{th j-a}	thermal resistance from junction to ambient	note 1	500	K/W

Note

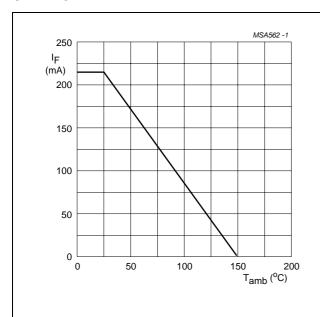
1. Device mounted on an FR4 printed-circuit board.

1996 Sep 10 3

High-speed double diode

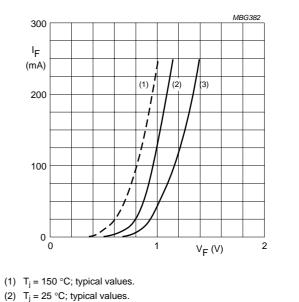
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GRAPHICAL DATA

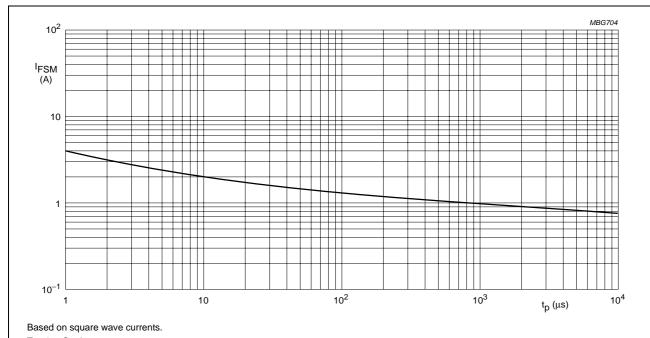


Device mounted on an FR4 printed-circuit board.

Fig.2 Maximum permissible continuous forward current as a function of ambient temperature.



- (3) T_j = 25 °C; maximum values.
 - Fig.3 Forward current as a function of forward voltage.



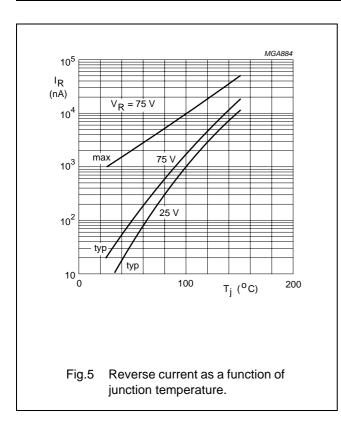
 T_j = 25 °C prior to surge.

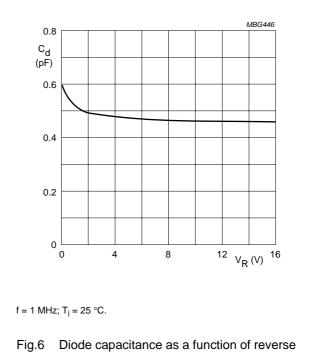
Fig.4 Maximum permissible non-repetitive peak forward current as a function of pulse duration.

1996 Sep 10 4

High-speed double diode

BAS28



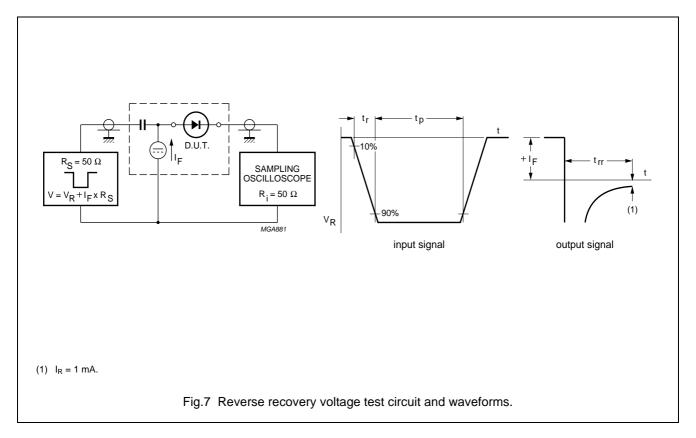


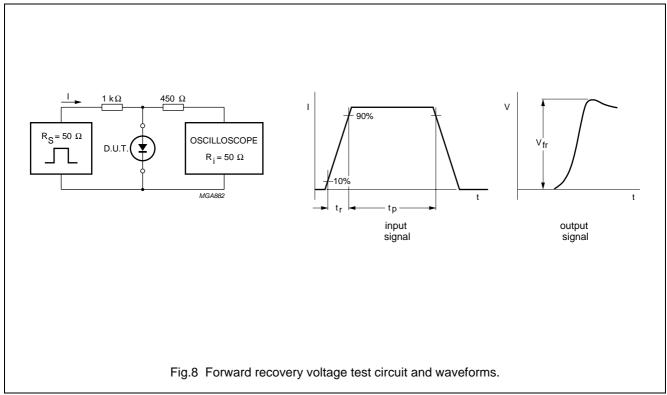
voltage; typical values.

1996 Sep 10 5

High-speed double diode

BAS28



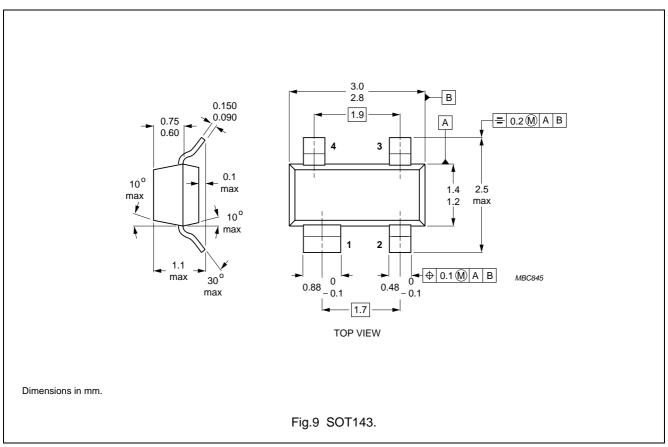


6

High-speed double diode

BAS28

PACKAGE OUTLINE



7

High-speed double diode

BAS28

DATA SHEET STATUS

DOCUMENT STATUS ⁽¹⁾	PRODUCT STATUS ⁽²⁾	DEFINITION
Objective data sheet	Development	This document contains data from the objective specification for product development.
Preliminary data sheet	Qualification	This document contains data from the preliminary specification.
Product data sheet	Production	This document contains the product specification.

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